

# **11069 DSO** DSO Debug Techniques for Embedded Systems



## **Class Objective**

#### When you finish this class you will:

- Learn (presentations, hands on and Q&A) about capabilities and features on modern DSO equipment for testing the mixture of digital and analog signals in embedded systems
- Understand system debug techniques for embedded systems using digital scopes
- Know how to choose the right tools for your embedded system needs



## **Class Objective**

#### Abstract

In this hands-on workshop, you will use the capabilities and features of the modern Digital Storage Oscilloscope (DSO) to investigate and debug system level issues. Focus will be on practical examples of how to acquire, view, measure and analyze the mixture of digital and analog signals present in modern embedded systems. Examples include CANbus, LIN, I<sup>2</sup>C<sup>™</sup>, RS-232, SPI, generic UART's, Flexray and other types of data buses.

#### **Prerequisites**

- Basic knowledge of electronic measurements



## Agenda

#### **Review Typical Embedded Controller Environment**

- Types of signals
- Issues on timing
- Digital parallel data transfers and serial communications

#### Techniques to make debugging easier

- Test equipment tools to validate designs and looking for signal anomalies
- Utilizing oscilloscopes for both Physical Layer and Data Link Layer information
- Graphical tools to make debug easier and faster
- Knowing more about your embedded system design than you expected...

#### We will blend Lecture & Labs together...seamlessly



# **Embedded System Testing**

#### What is the Basic Need?

- Engineers want to use a high quality 4 channel scope to view key signals with high sampling rate, long memory, good triggering and easy to use measurements. But they also need to view many lines of digital addresses/data.
- Probe the Electrical Signals without changing their shape (PRB 11068)
- Analog and Digital start up sequencing and data messaging are difficult to analyze and are important in validating a embedded design
- It can be cumbersome (and expensive) to use an oscilloscope and a logic analyzer



## **Embedded System Testing**

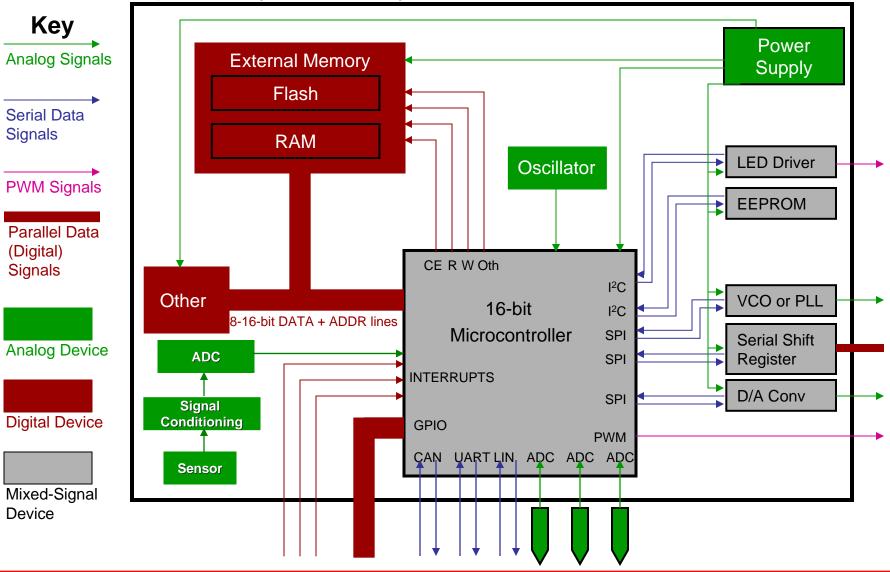
### What is the Basic Need?

- As digital signals become faster they take on more properties that previously were attributed only to analog signals
- Digital engineers are starting to worry about signal rise time, overshoot, ringing, pulse widths and other types of "analog" properties
- They also need to capture and view the timing of many digital lines, find errors and troubleshoot system performance
- Let's take a look at a typical embedded system



# **A Typical Embedded Controller**

(Your System may have some/all of these elements)





## What Engineers Say – What do you say? *Discussion*

#### **The Need for Performance**

- "My signals are often faster than 125 MHz, even up above 250 MHz"
- "We need longer memory, 1 Meg is not always enough, we like to capture a lot of digital messages in a single trigger"

#### The Need for Channels

 "Provide me with enough channels for address lines, data lines, control lines and serial data lines; sometimes we use 20 or 32"

#### The Need for Simplicity

- "External MSOs are great because I can get closer to my board but it must be easy to set up"
- "Make the MSO simple so I can use it just like my scope"

#### The Need for Serial Data Analysis

- "Give me an easy way to understand data bus traffic and trigger or search for specific data messages"
- "Make the decoded information easy to read quickly"
- "Let me capture and decode data busses on the MSO inputs and leave the scope channels open for other signals"



## **Breaking Down the Measurement**

### Capture

- Use the right trigger (combination of digital and analog conditions)
- Use long memory at high sample rate for most accurate capture of both the digital and analog signals
- Triggering on a certain data value or ID can be useful

View

- A large display with room for all the signals is very useful
- View digital lines individually or as bus values

#### Measure

 Use scope cursor and parameter measurements on digital lines in the same fashion as on analog signals



# Lab - Analog Triggering

# Introduction to the lab signal (WaveSource 100) Signal On Screen Edge, Slope



## Lab – Needle In the Haystack

# Today's Oscilloscopes – Sample rate & memory

## Navigating Through Memory to Identify Design Problems



## Overview One Method for Capture and View of Mixed Signals

Capture signals on analog inputs with bandwidths up to 2 GHz and sampling rate up to 10 GS/s

Trigger on and decode serial data signals such as I<sup>2</sup>C<sup>™</sup>, SPI, UART, RS-232, CAN and LIN

Long captures of digital signals up to 500MHz with up to 50 Mpts/ch memory

View digital signals as individual lines or as a bus

Capture long records of analog signals with up to 12.5 Mpts/ch





## Triggering on a Mixture of Analog and Digital Conditions

Digital channel as a source for oscilloscope trigger

Digital channel as a source for serial data trigger





Analog/Digital Cross Pattern Trigger





## Analog, Digital and Cross Triggering Capabilities

# Use basic or complex triggers on any of the analog or digital lines

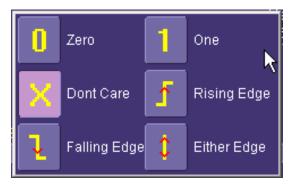
- Edge, Width, Glitch, Interval, Dropout

#### Pattern trigger can be used to set a simple or complex pattern using any combination of analog and digital channels

- Choose between 1, 0, rising edge, falling edge, either edge or don't care trigger conditions
- Bus Trigger Create a digital trigger that corresponds to a hexadecimal bus value for up to 36 digital bits
- Qualified Event Trigger Arm the trigger on an analog signal and trigger on a pattern or use one pattern to arm the trigger for a second pattern









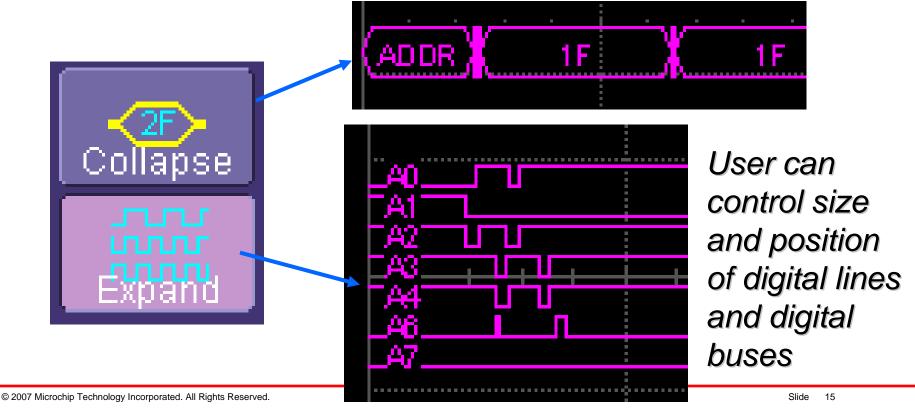




## **Viewing Digital Waveforms**

#### Digital logic lines can be grouped into "buses" and displayed as a bus view

- Saves display area
- •Makes interpretation easier
- •Can make trigger setup easier





## **Cursors and Measurements**

Use common oscilloscope tools to measure digital signals

Measurements may be used with Digital Channels



Frequency



Period



Width

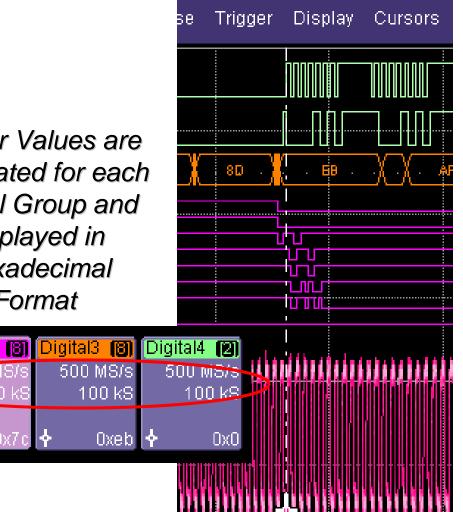


Delay



**Duty Cycle** 

Cursor Values are Calculated for each Digital Group and displayed in Hexadecimal Format



0x7c

Didital1

500 MS/

I N N I



#### CAN Bus Message Decoding (note the use of long memory and zoom)

Capture Seconds Worth of CAN Traffic

Message Decoding Provides Quick and Easy View of Frame Information

Both Standard and Extended CAN ID's Supported

CAN Zoom Provides Details of Each Frame's Physical Layer Characteristics





# UART and RS-232 Trigger and Decode

Trigger and decode on RS-232 or generic UART busses

Customizable UART settings allow for the trigger and decode of proprietary busses using a UART backbone

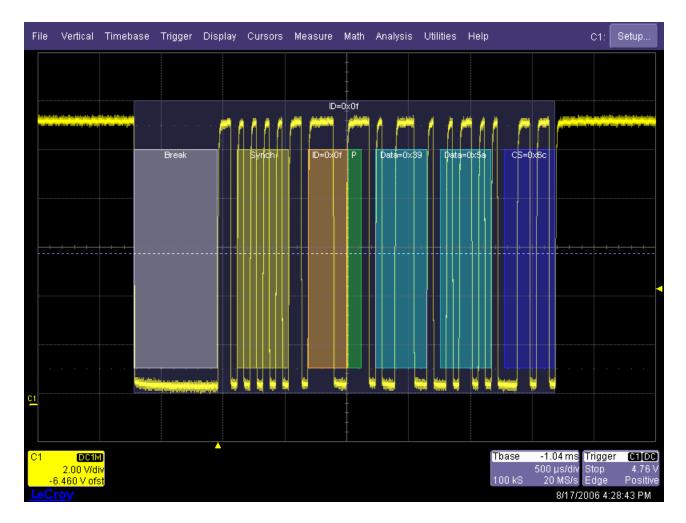
Built in support of 9 bit UART

Conditional triggering for UART messages which are less than, greater than or in or outside a specified range <u>File Vertical Timebase</u> Trigger Display Cursors Measure Math Analysis Utilities Help C1: Setup. Data = 0x73 Data = 0x87 Data = 0v45 DC1M Tbase -2.00 ms Trigger C1 DC 5.00 V/div Stop -2.75 V ofs: 100 kS Positiv 8/17/2006 5:42:25 PM



## LIN Trigger and Decode

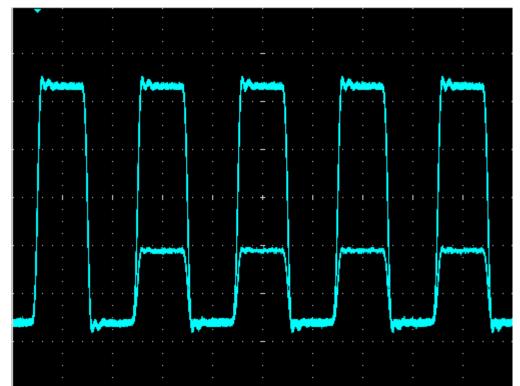
- Full support of LIN 1.3, 2.0 and J2602
- Trigger on Break (Start of Frame), Message ID, Message ID + Data and Error Frames
- Multiple Error triggers available for checksum, header parity and sync byte errors
- Conditional triggering for LIN messages which are less than, greater than or in or outside a specified range





## **Debug Tool for Intermittent Signal Faults**

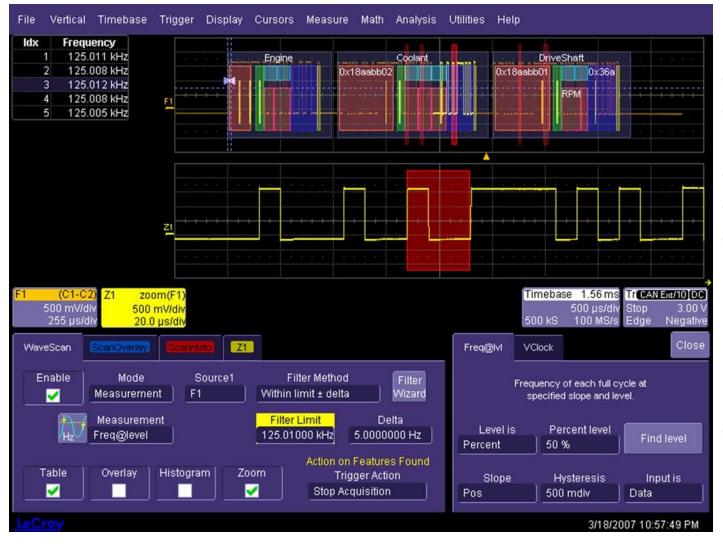
- The Replay Mode feature is a unique feature in the WaveJet class of scopes (100-500 MHz)
- In Normal or Auto trigger mode WaveJet captures runts, glitches, etc
- When the trigger is stopped and Replay Mode is activated a history of the waveform is displayed
- The history of all acquisitions can be seen in page mode and rotating the knob flips through the acquisitions



The Replay mode can be very useful for debugging intermittent faults in either analog or digital lines. It lets you see the individual signal acquisitions that built up the persistence display

on the screen of the scope.





In this example the scope scans the data in a digital line to look for improper frequency of data transitions.

This can be done on a long record of captured data or as a "soft trigger" monitoring the live data coming into the scope.



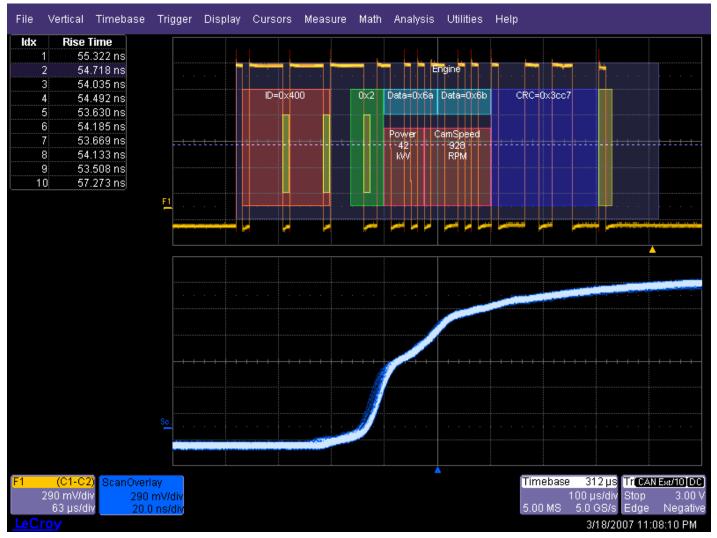


This example shows detection of a "runt" pulse.

The signal goes to logic low, then passes through the 10% level without attaining the 90% level.

The user can set the voltage levels which define "runt".





This example shows detection of an improper rise time.

The example is a CANbus signal. Note the decoding of the ID, data values and CRC of the CAN packet.





In this example the scope scans the waveform for non-monotonic edges.

Reflections, glitches, metastable states and other types of circuit faults can be spotted using this technique.



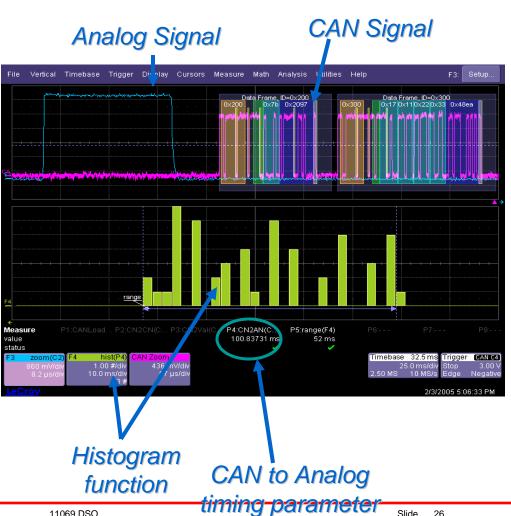
## Lab

# Debug & Analysis – WaveScan



(the next several slides will show an example of using histograms to troubleshoot a timing problem between an analog line and a digital line)

- The Evolution of **Debug/Analysis** Tools
- **Automated Timing** Measurements replaced cursors
- Capture thousands or millions of events
- Graph and understand statistical significance of data
- Ensure that worst case events are understood and designed out



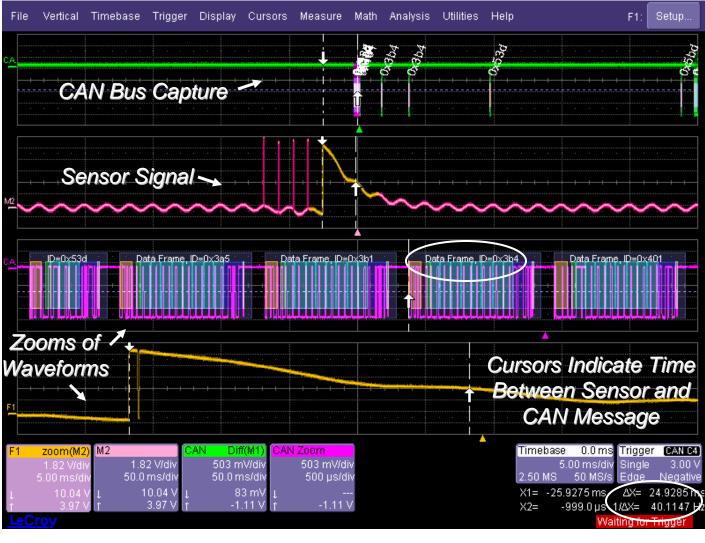


<u>Goal:</u> Measure Time from Sensor to Specific CAN Frame

Procedure: CAN Trigger Captures Data Frame of Interest (ID=0x3b4)

Scope Captures Analog Signal from Sensor

Timing from Sensor's 5<sup>th</sup> Edge to CAN Data Frame's SOF is Measured with Cursors



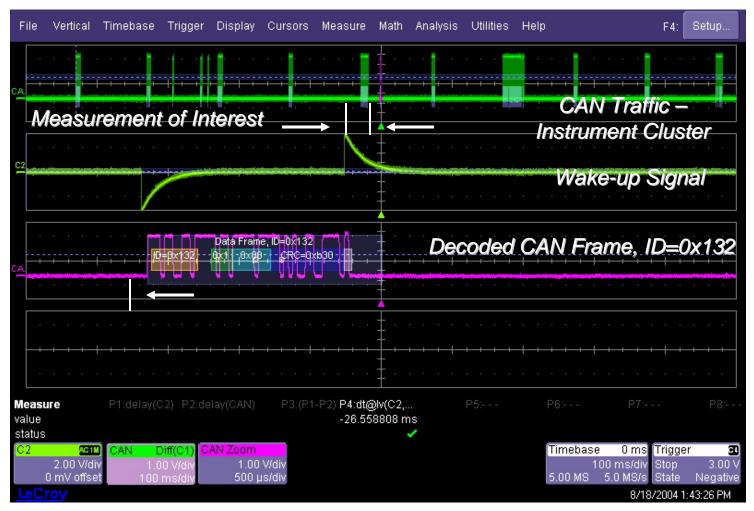


#### Goals:

Determine Time from Wake-up Signal to Specific CAN Frame

Accurately Determine Message Latency

Gain Insight to Variance in These Latency Values





First Step: Define CAN Trigger Condition – Trigger on Data Frame

with ID = 0x132

Bit Rate		ID definition			Data definition	
	Frame Type	ID condition	ID Bits	Data condition	DLC	
33333 bit/s	Data	=	STD(11 bit)	DontCare	8	
Non-standard		ID	to ID	Data Value		
		0x132	0x00	0x00	0x00	
Shortcut to	Input Ack]			Start Bit	#Data Bit	

#### Second Step: Setup State Trigger to Find Wake-up Signal as Pre-Qualifier for CAN Trigger

Trigger CAN Trigger					Close
Edge Width Glitch	Trigger Source CAN C4	Positive	After Qualifier	After qualified, wait:	
Interval Qualify State	Coupling DC	Negative	has gone Below Level	Events	Trigger with edge trigger
Dropout Logic	Level 3.00 V	Zero Level	3.00 V Coupling DC	Qualify first segment only	settings only after a second qualifying condition is satisfied and stays satisfied.



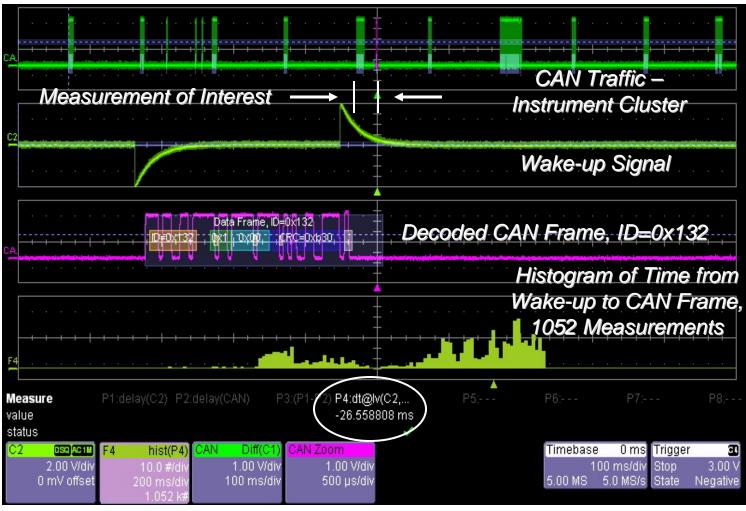
**Results:** 

State Triggering Coupled with CANbus TD Captures Signals of Interest

CAN Decoding Provides CAN Message Details

Measurement Parameters Provide Timing of Message Latency

Histograms Provides Insight to Variance of Latency Values





#### Debug/Analysis Tools (tracks of parameter values)

# In this example the scope:

- Extracts decimal data from a specific CAN Messages
- Rescale to user-defined units
- Plots data
- Understand correlation with analog signal information



#### CAN to Value

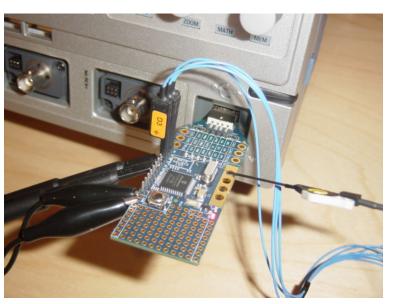
*timing parameters* 



## **Lab- MSO Applications**

#### **Use the WaveSource 100 Digital Pattern Pins**

- Connect digital leads to pins D0 D3, connect passive probes from C1 and C2 on the scope to D4 and D5 respectively
- Connect one of the grey ground leads with a gripper to the WaveSource 100 ground plane
- Set Digital Group 1 to display D0 D3 and set an edge trigger on D3
  - This shows how digital channels are completely integrated into the oscilloscope, all digital channels can be used as sources for scope triggers, edge, width, interval, etc
- Turn on C1 and C2 and set up a pattern trigger with these values
  - C1 1, C2 0, D3 1, D2 0, D1 1, D0 0 and note the trigger position
  - In 100 us/div you can see that the proper trigger condition is met, see screenshot on this slide
  - This shows our new cross pattern triggering, the user can create simple or complex trigger patterns consisting of up to 4 analog and 36 digital channels
- Turn on Horizontal Absolute cursors and show how cursors read out timing measurements and digital bus values below the waveform grid
- Turn on measurement parameters and show how they work on both analog and digital channels
  - Try Period, Frequency, Width, Duty Cycle, Delay, Delta Delay
- Turn on long memory by going to the timebase menu and turn it up to 50 Mpts, turn back the T/div and show how much data can be captured – Use the zoom along with the touch screen







## Lab- Serial Data Trigger and Decode

- The MS-500 and MS-250 are capable of serial data trigger and decode
- The TD packages for I<sup>2</sup>C<sup>™</sup>, SPI, UART and LIN all work with digital inputs

Setup

- Use any digital lines and set them up in Digital Group 1
- Then from the touch screen select the proper sources for data and/or clock just as you would an analog scope channel
- Trigger and Decode using the digital lines. Save the scope channels for important analog signals



## Lab- UART/RS-232

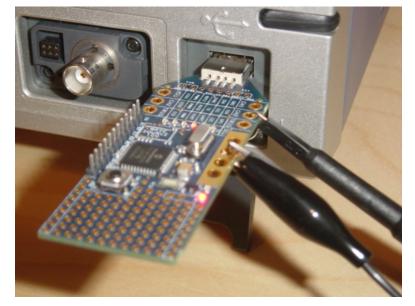
- Use Ch2 of test device WS 100 and press the switch twice until the S3 LED is blinking
- Connect a passive probe from C1 of the scope to Ch2 and ground the probe
- Set an edge trigger on C1 and select 50 us/div
- Enter Decode Menu, select UART and the source as C1

Set the following parameters and turn the decode on

- Bitrate 1 Mbps, Data bits 8, Parity None, Stop Bits – 2, Bit Order – LSB, Polarity – Idle High
  - Your display should match the screenshot on the bottom of this slide
- The color coded decode overlay lets the user quickly scan through captured data for the bytes they are looking for
- Switch between Hex, Binary and ASCII to show that decoded data can be displayed in several different ways
- Increase the memory to 5 Mpts and change the timebase to 20 ms/div
- Turn on the table and show how easy it is to locate message in long captures
- Select an entry in the table and click on it, a zoom takes you right to the data of interest

Enter the trigger menu, confirm the proper settings and set the trigger as desired

- Set the trigger on any of the following data bytes to show how the trigger works - 4C, 65, 6F, 20
- Try a conditional trigger by selecting one of the trigger conditions and any data byte you see decoded on the screen







# Choosing the Lab Tools for Your Embedded System Needs



## **Equipment Considerations**

- There are three basic types of scope architectures for capture of signals from embedded systems.
  - 1. Use an oscilloscope and a separate logic analyzer (expensive and complicated- but has the performance needed for data rates 1 GHz and faster)
  - 2. Use an oscilloscope with a built in attachment for capturing digital lines (typically limited to 16 digital lines with short memory and 250 MHz data rate)
  - 3. Use an optional external module that captures digital signals which are then transferred into the scope (easier to share, easier to get short lines from DUT to module, up to 36 digital lines with long memory, up to 500 MHz digital signals, up to 2 GHz analog signals)



## **Elements of an MSO Option**

#### **High Performance**

- Max Input Frequency for digital signals
- Measured as Max Sampling Rate

#### Long Memory

-Length of digital signal

-Should relate well with scope memory

#### Display

- How to see and overlay analog and digital



#### **More Channels**

#### **Easy Setup**

- -Simple Connection to Oscilloscope
- Quality of Integration

#### Easy to Operate

- Intuitive User Interface
- Compare analog with digital inputs and then measure

#### **Price/Performance**

- 8, 16, 32 or more on 2 or 4 ch scope



# These Qualities appear in all spec sheet

	MS-500	MS-500-36	MS-250		
Maximum Input Frequency	500 MHz	250 MHz	250 MHz		
Max Sample Rate	2 GS/s	1 GS/s	1 GS/s		
Acquisition Memory	50 Mpts/ch	25 Mpts/ch	10 Mpts/ch		
Number of Channels	18	36	18		
Threshold Groupings	D0-D8, D9-D17	D0-D8, D9-D17, D18-D26, D27-D35	D0-D8, D9-D17		
Threshold Levels	TTL, ECL, PECL, CMOS (2.5V, 3.3V, 5V), LVDS or User Defined				
Trigger Types	Edge, Width, Glitch, Pattern, Qualified, Interval, Dropout				
Serial Data Triggers (Optional)	I2C, SPI, UART, RS-232, LIN				
Trigger Sources	C1-C4, D0-D17	C1-C4, D0-D35	C1-C4, D0-D17		

#### **Courtesy LeCroy Corporation**



S

## **Accessories – Mictor Cables**

Mictor connection cable, 3" (7.62 cm) long, 38-pin (32 digital channels).

Mictor connection cable, 14" (35.56 cm) long, 38pin (32 digital channels). Maximum digital clock frequency with this lead set is 125 MHz.

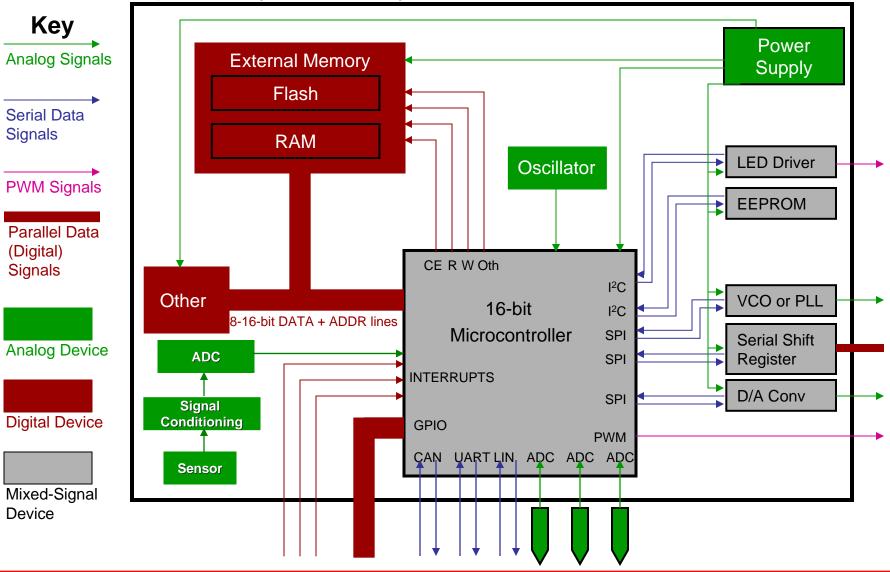


Note: Mictor cable connections do not allow precise time alignment of analog and digital signals on the oscilloscope. Use the blue cables for precise timing measurements.



# **A Typical Embedded Controller**

(Your System may have some/all of these elements)





## Summary

### Capture

- Use the right trigger (combination of digital and analog conditions)
- Use long memory at high sample rate for most accurate capture of both the digital and analog signals
- Triggering on a certain data value or ID can be useful

View

- A large display with room for all the signals is very useful
- View digital lines individually or as bus values

#### Measure

 Use scope cursor and parameter measurements on digital lines in the same fashion as on analog signals



## Summary

## Analysis

- Some scope option packages will allow you to decode and analyze bus traffic
- Graph (track) the values of key signal characteristics
- Histogram the timing between events
- Find the source of errors



## Literature

- Application Notes
- Tech Briefs
- Text Books



## Websites

### - Microchip Technology Inc.

- <u>www.microchip.com</u>
- LeCroy
  - www.lecroy.com



## **Web Seminars**



## **Demo Boards**



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